

**TO-252 N Channel Enhancement 沟道增强型  
MOS Field Effect Transistor 场效应管**

**■ Features 特点**

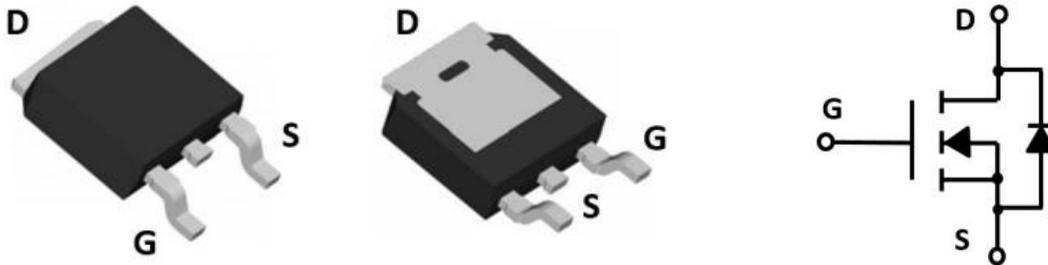
Low on-resistance 低导通电阻  
 $R_{DS(ON)}=2m\Omega(\text{Type})@V_{GS}=10V$   
 $R_{DS(ON)}=2.6m\Omega(\text{Type})@V_{GS}=4.5V$

**■ Applications 应用**

Backlight Drive 背光驱动  
 DC-DC Conversion 升压转换  
 Power Management 电源管理



**■ Internal Schematic Diagram 内部结构**



**■ Absolute Maximum Ratings 最大额定值**

Characteristic 特性参数	Symbol 符号	Rat 额定值	Unit 单位
Drain-Source Voltage 漏极-源极电压	$BV_{DSS}$	60	V
Gate- Source Voltage 栅极-源极电压	$V_{GS}$	$\pm 20$	V
Drain Current (continuous)漏极电流-连续	$I_D$ (at $T_C = 25^\circ\text{C}$ )	160	A
Drain Current (pulsed)漏极电流-脉冲	$I_{DM}$	480	A
Total Device Dissipation 总耗散功率	$P_{TOT}(\text{at } T_C = 25^\circ\text{C})$	320	W
Thermal Resistance Junction-Case/Ambient 热阻	$R_{\theta JC}$ $R_{\theta JA}$	0.39 62.5	$^\circ\text{C}/\text{W}$
Avalanche Energy Single Pulse 雪崩能量	$E_{AS}$	270	mJ
Junction/Storage Temperature 结温/储存温度	$T_J, T_{stg}$	150 $^\circ\text{C}$ , -55~150 $^\circ\text{C}$	

**Electrical Characteristics 电特性**

 (T<sub>A</sub>=25°C unless otherwise noted 如无特殊说明, 温度为 25°C)

Characteristic 特性参数	Symbol 符号	Min 最小值	Typ 典型值	Max 最大值	Unit 单位
Drain-Source Breakdown Voltage 漏极-源极击穿电压(I <sub>D</sub> =250uA, V <sub>GS</sub> =0V)	BV <sub>DSS</sub>	60	—	—	V
Gate Threshold Voltage 栅极开启电压(I <sub>D</sub> =250uA, V <sub>GS</sub> =V <sub>DS</sub> )	V <sub>GS(th)</sub>	1.1	1.5	2.1	V
Zero Gate Voltage Drain Current 零栅压漏极电流(V <sub>GS</sub> =0V, V <sub>DS</sub> =60V)	I <sub>DSS</sub>	—	—	1	uA
Gate Body Leakage 栅极漏电流(V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V)	I <sub>GSS</sub>	—	—	±100	nA
Static Drain-Source On-State Resistance 静态漏源导通电阻(I <sub>D</sub> =30A, V <sub>GS</sub> =10V) (I <sub>D</sub> =20A, V <sub>GS</sub> =4.5V)	R <sub>DS(ON)</sub>	—	2 2.6	2.6 3.4	mΩ
Diode Forward Voltage Drop 内附二极管正向压降(I <sub>SD</sub> =30A, V <sub>GS</sub> =0V)	V <sub>SD</sub>	—	—	1.4	V
Input Capacitance 输入电容 (V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz)	C <sub>ISS</sub>	—	5460	—	pF
Common Source Output Capacitance 共源输出电容(V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz)	C <sub>OSS</sub>	—	1290	—	pF
Reverse Transfer Capacitance 反馈电容(V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz)	C <sub>RSS</sub>	—	13	—	pF
Total Gate Charge 栅极电荷密度 (V <sub>DS</sub> =30V, I <sub>D</sub> =10A, V <sub>GS</sub> =10V)	Q <sub>g</sub>	—	86	—	nC
Gate Source Charge 栅源电荷密度 (V <sub>DS</sub> =30V, I <sub>D</sub> =10A, V <sub>GS</sub> =10V)	Q <sub>gs</sub>	—	14	—	nC
Gate Drain Charge 栅漏电荷密度 (V <sub>DS</sub> =30V, I <sub>D</sub> =10A, V <sub>GS</sub> =10V)	Q <sub>gd</sub>	—	14	—	nC
Turn-ON Delay Time 开启延迟时间 (V <sub>DS</sub> =30V I <sub>D</sub> =60A, R <sub>GEN</sub> =4.7 Ω, V <sub>GS</sub> =10V)	t <sub>d(on)</sub>	—	20	—	ns
Turn-ON Rise Time 开启上升时间 (V <sub>DS</sub> =30V I <sub>D</sub> =60A, R <sub>GEN</sub> =4.7 Ω, V <sub>GS</sub> =10V)	t <sub>r</sub>	—	127	—	ns
Turn-OFF Delay Time 关断延迟时间 (V <sub>DS</sub> =30V I <sub>D</sub> =60A, R <sub>GEN</sub> =4.7 Ω, V <sub>GS</sub> =10V)	t <sub>d(off)</sub>	—	95	—	ns
Turn-OFF Fall Time 关断下降时间 (V <sub>DS</sub> =30V I <sub>D</sub> =60A, R <sub>GEN</sub> =4.7 Ω, V <sub>GS</sub> =10V)	t <sub>f</sub>	—	25	—	ns

■ Typical Characteristic Curve 典型特性曲线

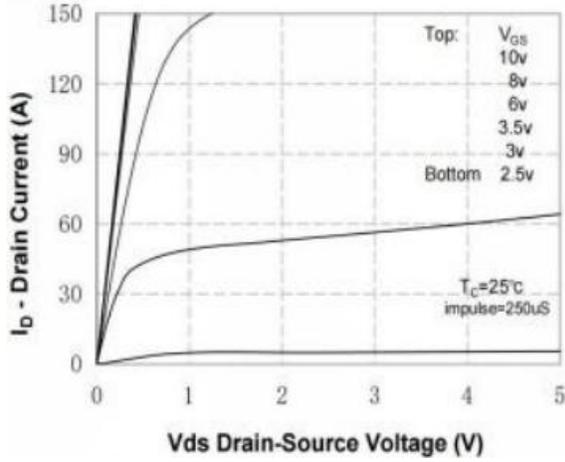


Figure 1: Output Characteristics

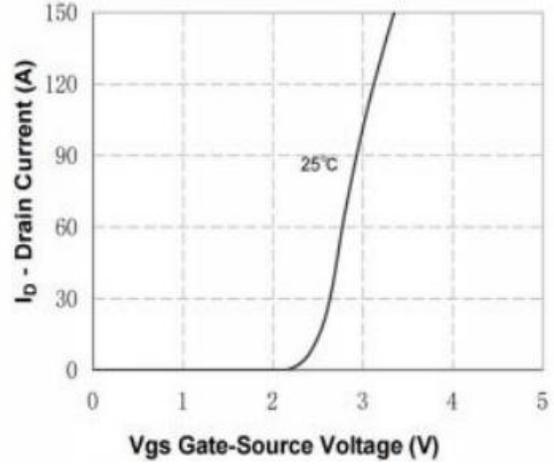


Figure 2: Transfer Characteristics

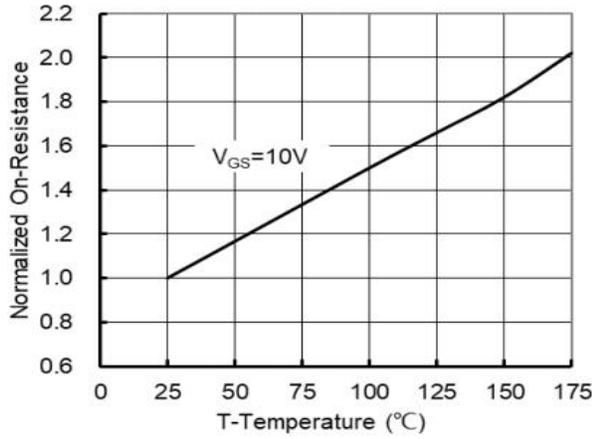


Figure 3: On-Resistance vs.  $T_j$

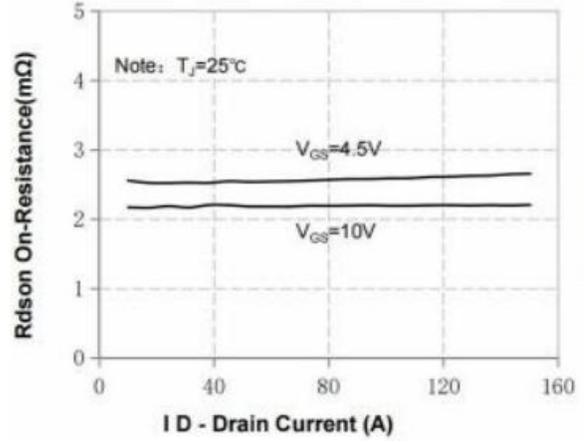


Figure 4: On-Resistance vs. Drain Current

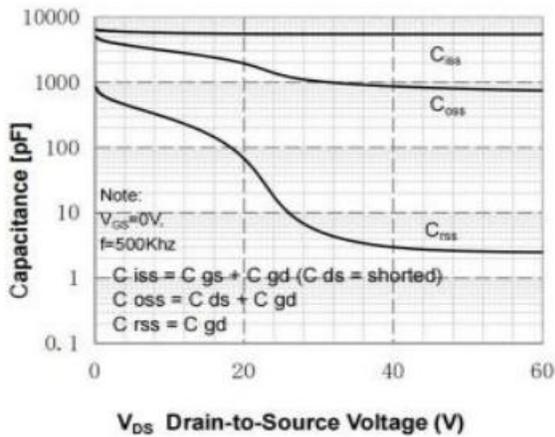


Figure 5: Capacitance Characteristics

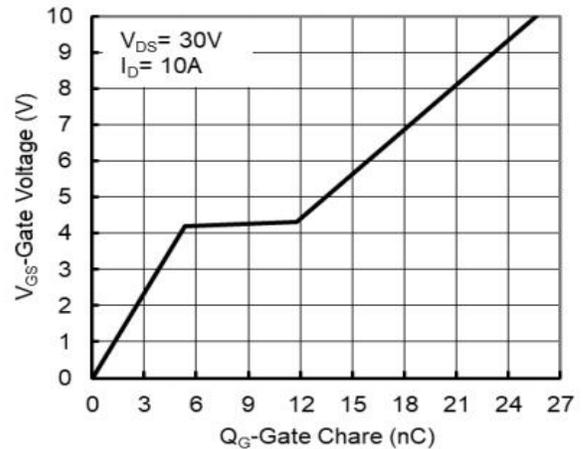


Figure 6: Gate-Charge Characteristics

■ Typical Characteristic Curve 典型特性曲线

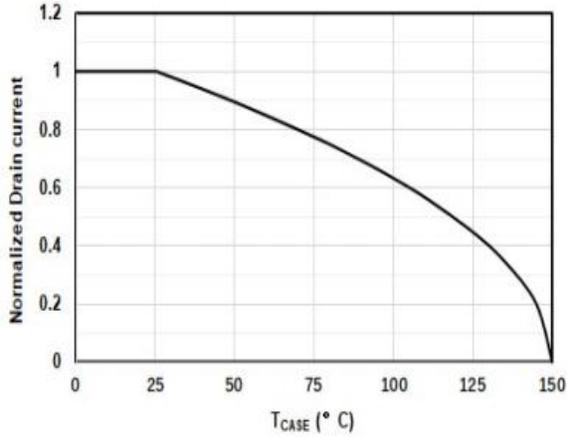


Figure 7: Drain Current Characteristics

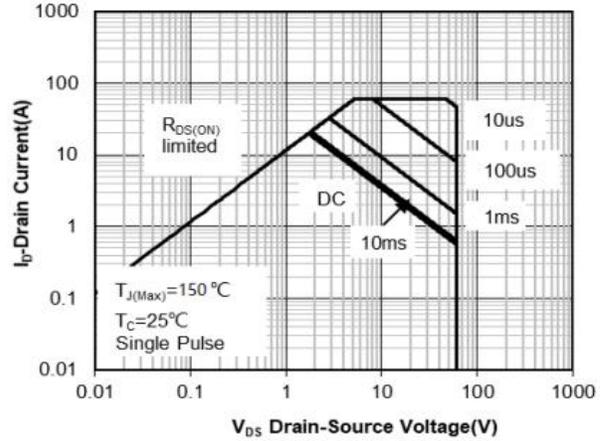


Figure 8: Safe Operating Area

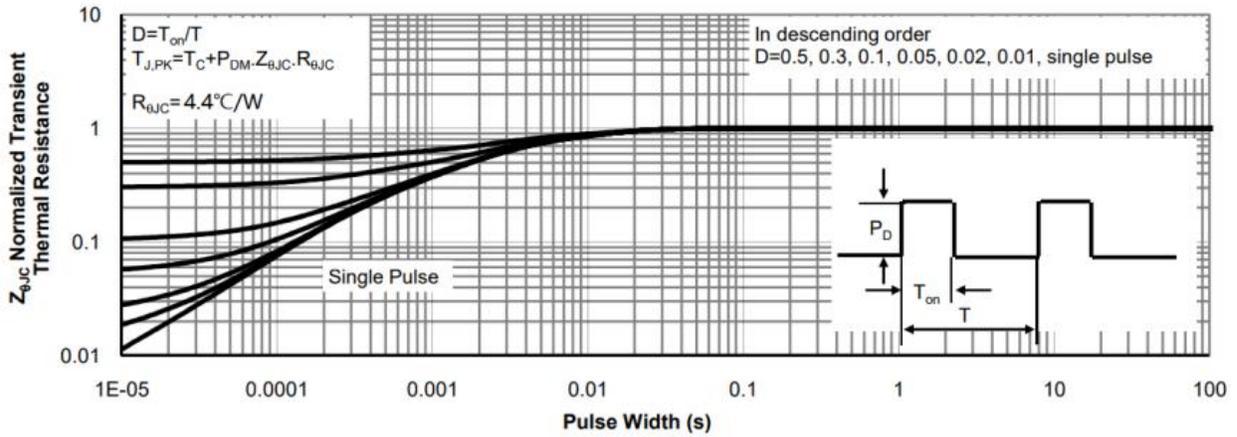
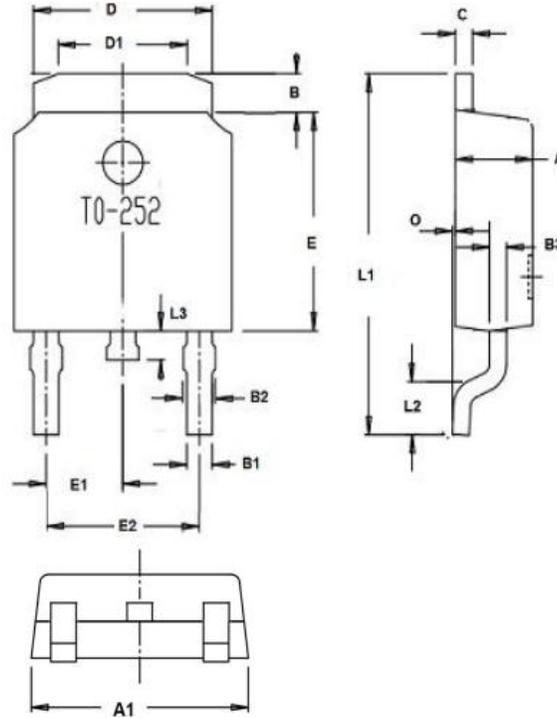


Figure 9: Transient Thermal Response Curve

■ Dimension 外形封装尺寸



Dim.	Min.	Max.
A	2.1	2.5
A1	6.3	6.9
B	0.95	1.55
B1	0.6	0.8
B2	0.75	0.95
C	Typ0.5	
D	5.3	5.5
D1	3.65	4.05
E	5.8	6.4
E1	Typ2.3	
E2	Typ4.6	
O	0	0.15
L1	9	11
L2	Typ1.5	
L3	0.7	1
All Dimensions in millimeter		